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| Search Notes  | Application/Control No. 10786137 | Applicant(s)/Patent Under Reexamination HYUN ET AL. |
| | Examiner Lee, Andrew Hwa S. | Art Unit 2877 |

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| Notes | Date | Examiner |
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| | <p>Examiner</p> <p>Lee, Andrew Hwa S.</p> | <p>Art Unit</p> <p>2877</p> |

| Class | SubClass | Date | Examiner |
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| 356 | 237.1 | 8/21/06 | AHL |
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| 356 | 237.1 | 8/21/06 | AHL |
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